

Description

The SX1N10I uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 100V$ $I_D = 1.5A$

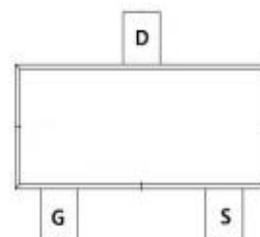
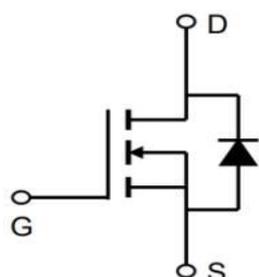
$R_{DS(ON)} < 500m\Omega$ @ $V_{GS}=10V$

Application

Atomizer

Load switch

Uninterruptible power supply



Absolute Maximum Ratings ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_A=25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	1.5	A
$I_D @ T_A=100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V^1$	1.2	A
I_{DM}	Pulsed Drain Current ²	6	A
$P_D @ T_A=25^\circ C$	Total Power Dissipation ³	1.2	W
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ C$
$R_{\theta JA}$	Thermal Resistance Junction-ambient ¹	104	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	75	$^\circ C/W$

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	100			V
IDSS	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1	μA
IGSS1	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V			±100	nA
IGSS2		V _{GS} =±10V, V _{DS} =0V			±50	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D =250μA	1.2	1.8	2.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =1.5A		430	500	mΩ
R _{DS(ON)}		V _{GS} =4.5V, I _D =1A		460	550	
C _{iss}	Input Capacitance	V _{DS} =10V, V _{GS} =0V, f=1MHZ		232		pF
C _{oss}	Output Capacitance			23		pF
C _{rss}	Reverse Transfer Capacitance			24		pF
Q _g	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =2A		6.47		nC
Q _{gs}	Gate-Source Charge			1.27		nC
Q _{gd}	Gate-Drain Charge			1.29		nC
Q _{rr}	Reverse Recovery Charge	I _F =2A, di/dt=100A/us		18.1		nC
t _{rr}	Reverse Recovery Time			36.9		ns
t _{D(on)}	Turn-on Delay Time	V _{GS} =10V, V _{DS} =50V, I _D =1.3A R _{GEN} =1Ω		4.6		ns
t _r	Turn-on Rise Time			18		ns
t _{D(off)}	Turn-off Delay Time			16		ns
t _f	Turn-off fall Time			27.4		ns
V _{SD}	Diode Forward Voltage	I _S =1.5A, V _{GS} =0V			1.2	V

Note :

- 1、 The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3、 The power dissipation is limited by 150°C junction temperature
- 4、 The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics

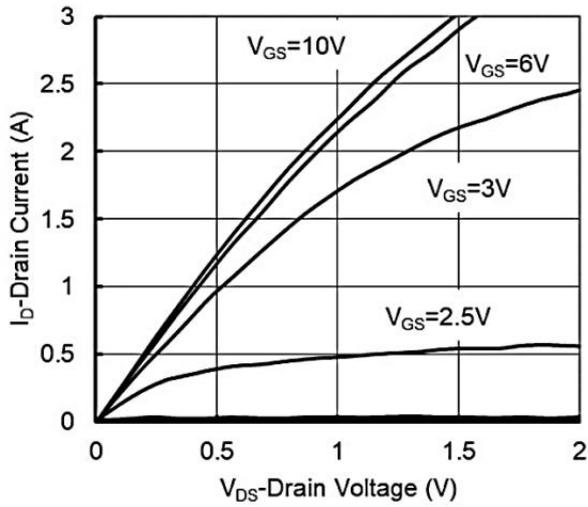


Figure1. Output Characteristics

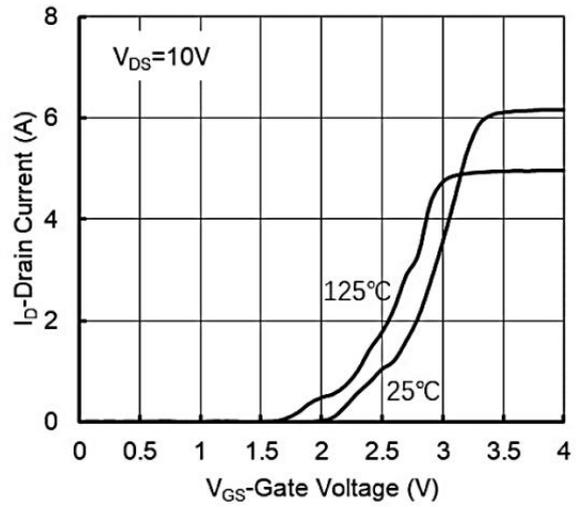


Figure2. Transfer Characteristics

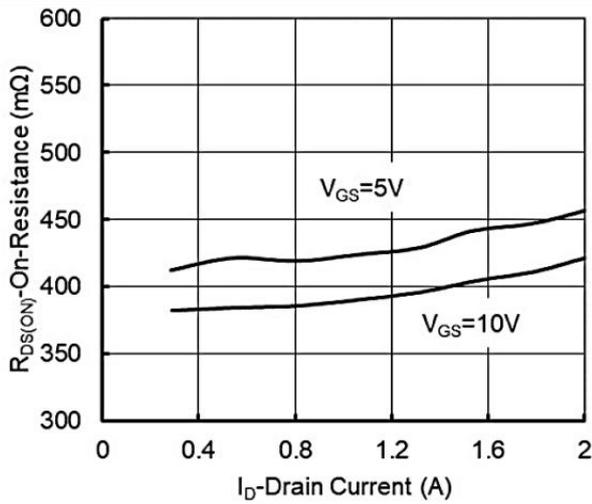


Figure 3: On-Resistance vs. Drain Current

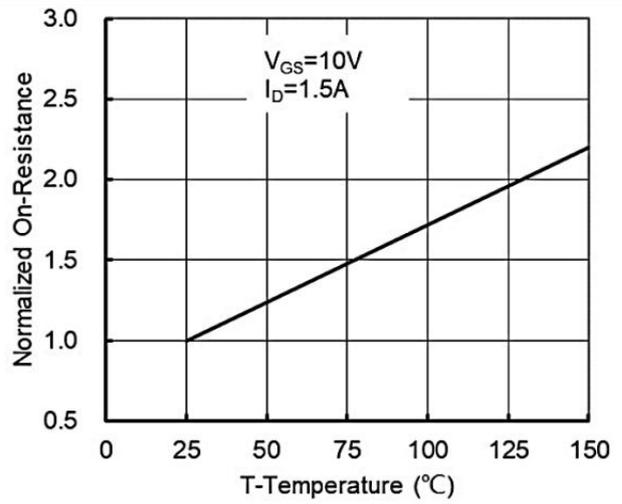


Figure 4: On-Resistance vs. Junction Temperature

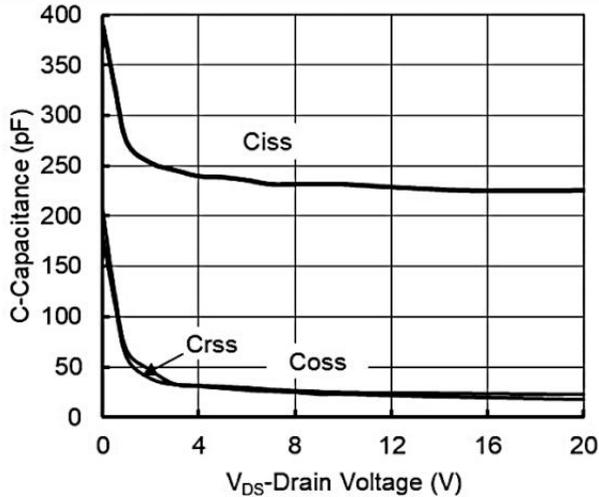


Figure5. Capacitance Characteristics

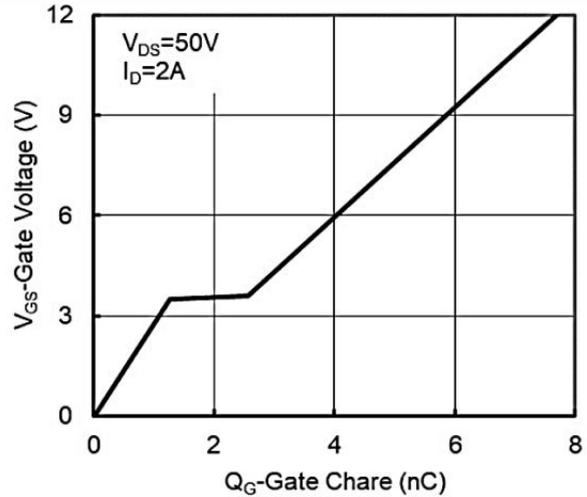


Figure6. Gate Charge

Typical Characteristics

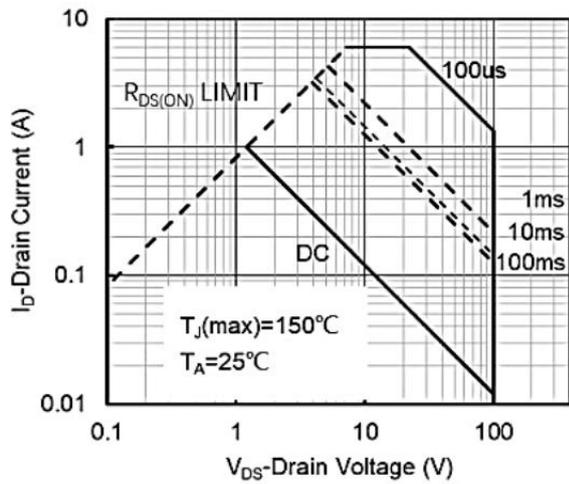


Figure 7. Safe Operation Area

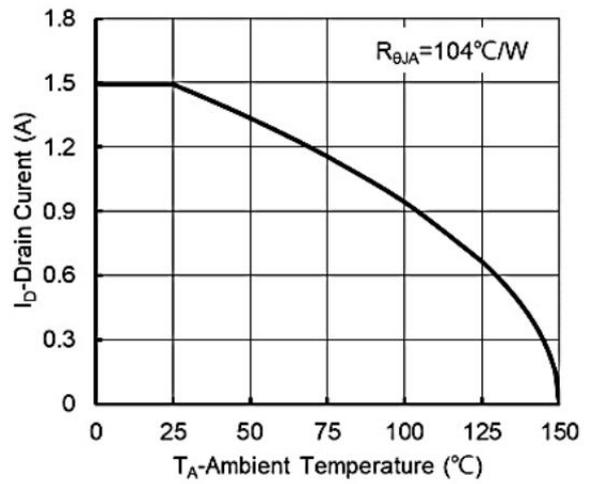


Figure 8. Maximum Continuous Drain Current vs Ambient Temperature

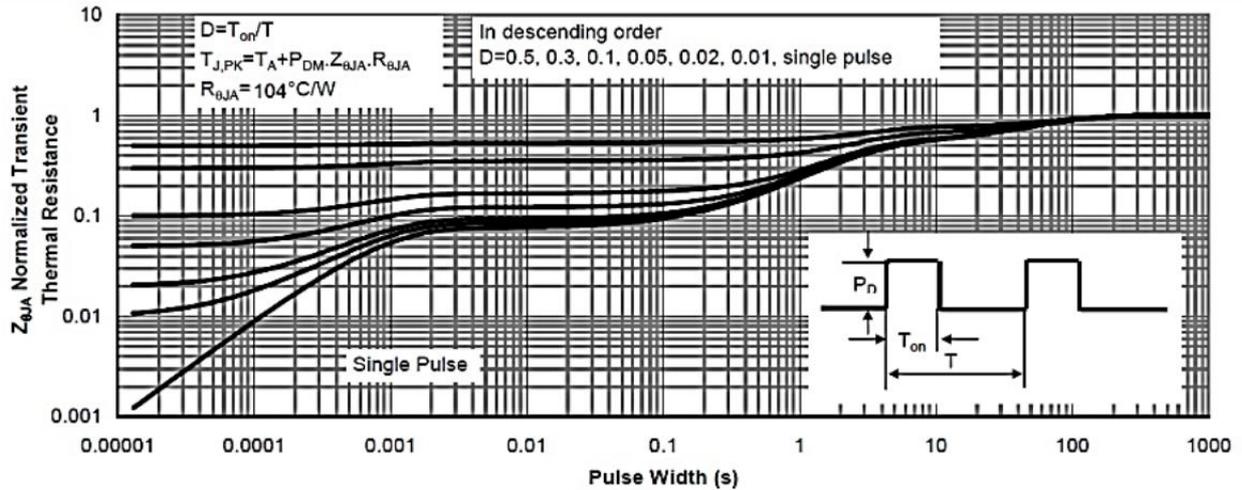
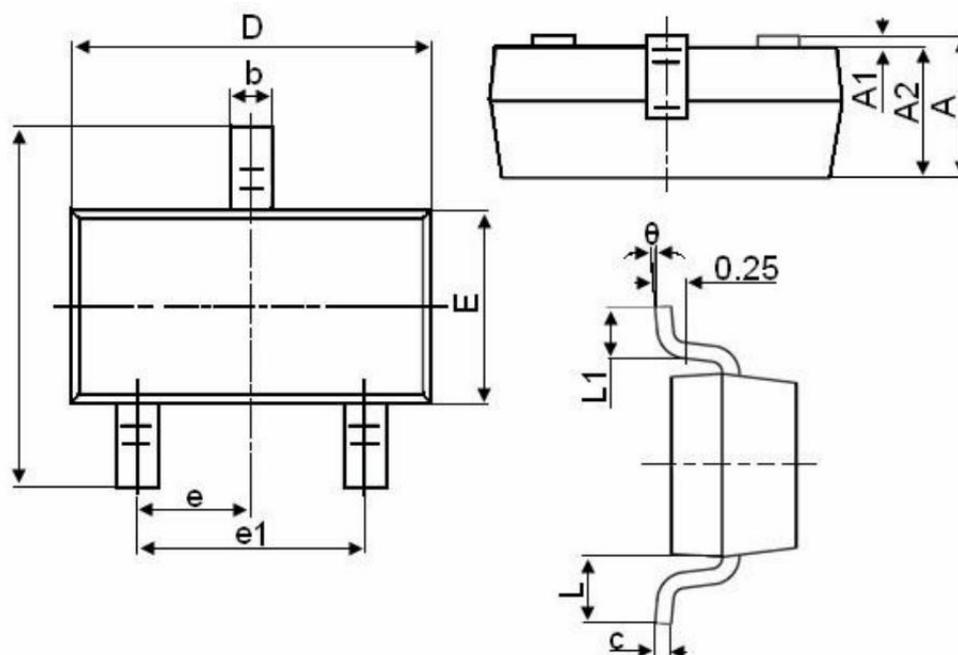


Figure 9. Normalized Maximum Transient Thermal Impedance

MOSFET ackage Mechanical Data-SOT23-XC-Single



Symbol	Dimensions in Millimeters	
	MIN.	MAX.
A	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
E	1.200	1.400
E1	2.250	2.550
e	0.950TYP	
e1	1.800	2.000
L	0.550REF	
L1	0.300	0.500
θ	0°	8°

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
TAPING	SOT23		3000